

WM1A080120K1

N-Channel SiC Power MOSFET

V_{DS}	=	1200 V
$R_{DS(on)}$	=	80 mΩ
$I_D@25^{\circ}C$	=	36 A

Features

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitance
- Easy to Parallel and Simple to Drive

Benefits

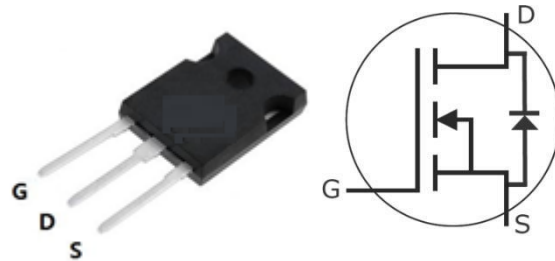
- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

Applications

- Power Supplies
- High Voltage DC/DC Converters
- Motor Drives
- Switch Mode Power Supplies

- Pulsed Power applications

Package



Part Number	Package
WM1A080120K1	TO-247-3

Maximum Ratings ($T_c=25^{\circ}C$ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
V_{DSmax}	Drain-Source Voltage	1200	V	$V_{GS}=0V, I_D=100\mu A$	
V_{GSmax}	Gate-Source Voltage	-10/+25	V	Absolute maximum values	
V_{GSop}	Gate-Source Voltage	-5/+20	V	Recommended operational values	
I_D	Continuous Drain Current	36	A	$V_{GS}=20V, T_c=25^{\circ}C$	
		24		$V_{GS}=20V, T_c=100^{\circ}C$	
$I_{D(pulse)}$	Pulsed Drain Current	80	A	Pulse width t_p limited by T_{Jmax}	
P_D	Power Dissipation	192	W	$T_c=25^{\circ}C, T_J=150^{\circ}C$	
T_J, T_{STG}	Operating Junction and Storage Temperature	-55 to +175	°C		



WM1A080120K1

Electrical Characteristics (T_c=25 °C unless otherwise specified)

Symbol	Parameter	Min.	Typ.	Max.	Unit	Test Conditions	Note
V _{(BR)DSS}	Drain-Source Breakdown Voltage	1200			V	V _{GS} =0V, I _D =100μA	
V _{GS(th)}	Gate Threshold Voltage	2.0	2.4	4.0	V	V _{DS} =V _{GS} , I _D =5mA	
			1.8			V _{DS} =V _{GS} , I _D =5mA, T _J =150 °C	
I _{DSS}	Zero Gate Voltage Drain Current		1	100	μA	V _{DS} =1200V, V _{GS} =0V	
I _{GSS+}	Gate-Source Leakage Current		10	250	nA	V _{DS} =0V, V _{GS} =25V	
I _{GSS-}	Gate-Source Leakage Current		10	250	nA	V _{DS} =0V, V _{GS} =-10V	
R _{DS(on)}	Drain-Source On-State Resistance		80	98	mΩ	V _{GS} =20V, I _D =20A	
			140			V _{GS} =20V, I _D =20A, T _J =150 °C	
C _{iss}	Input Capacitance		1475		pF	V _{GS} =0V	
C _{oss}	Output Capacitance		94			V _{DS} =1000V	
C _{rss}	Reverse Transfer Capacitance		11			f=1MHz	
E _{oss}	C _{oss} Stored Energy		52		μJ	V _{AC} =25mV	
E _{ON}	Turn-On Switching Energy		564		μJ	V _{DS} =800V, V _{GS} =-5V/20V	
E _{OFF}	Turn-Off Switching Energy		260			I _D =20A, R _{G(ext)} =2.5Ω, L=200μH	
t _{d(on)}	Turn-On Delay Time		9.3		ns	V _{DS} =800V, V _{GS} =-5V/20V, I _D =20A R _{G(ext)} =2.5Ω, R _L =40Ω	
t _r	Rise Time		9.5				
t _{d(off)}	Turn-Off Delay Time		18				
t _f	Fall Time		7.6				
R _{G(int)}	Internal Gate Resistance		3.1		Ω	f=1MHz, V _{AC} =25mV	
Q _{GS}	Gate to Source Charge		24		nC	V _{DS} =800V	
Q _{GD}	Gate to Drain Charge		15			V _{GS} =-5V/20V	
Q _G	Total Gate Charge		79			I _D =20A	

Reverse Diode Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
V _{SD}	Diode Forward Voltage	3.6		V	V _{GS} =-5V, I _{SD} =10A	
		3.3			V _{GS} =-5V, I _{SD} =10A, T _J =150°C	
I _S	Continuous Diode Forward Current		44	A	T _C =25°C	
t _{rr}	Reverse Recover Time	35		ns	V _R =800V, I _{SD} =20A dif/dt=290A/μs	
Q _{rr}	Reverse Recovery Charge	91		nC		
I _{rrm}	Peak Reverse Recovery Current	4.5		A		

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit	Test Conditions	Note
R _{θJC}	Thermal Resistance from Junction to Case	0.65		°C/W		
R _{θJA}	Thermal Resistance from Junction to Ambient		40			

Typical Performance

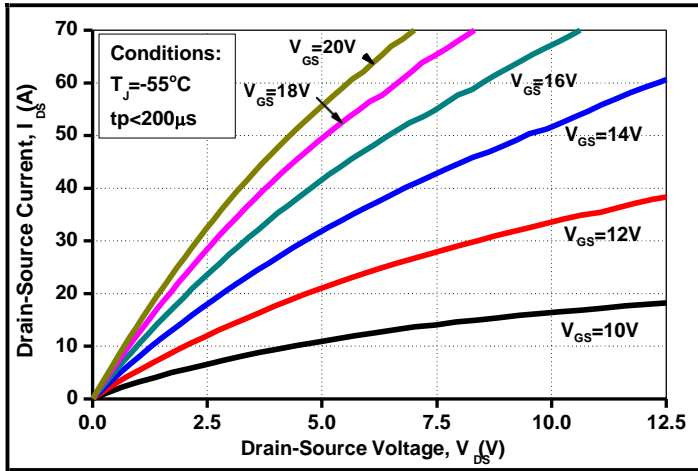


Figure 1. Output Characteristics $T_J = -55^\circ\text{C}$

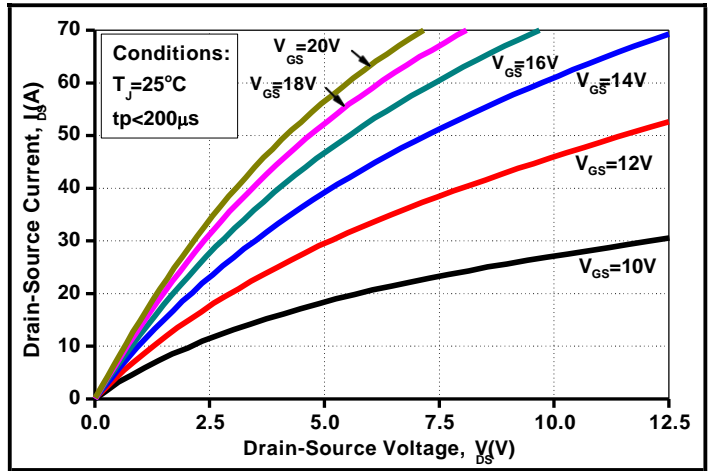


Figure 2. Output Characteristics $T_J = 25^\circ\text{C}$

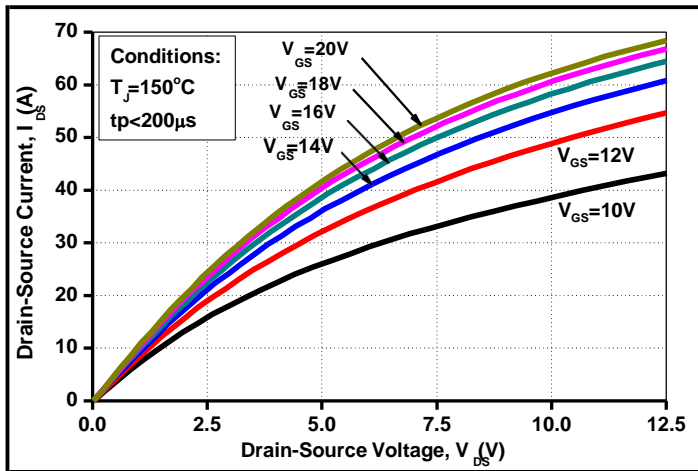


Figure 3. Output Characteristics $T_J = 150^\circ\text{C}$

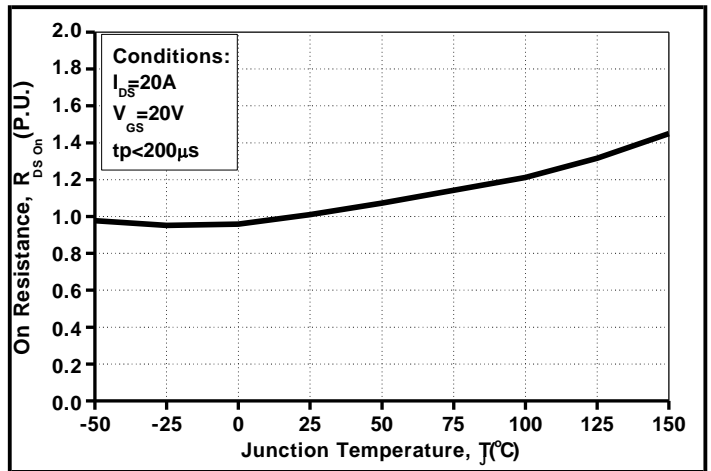


Figure 4. Normalized On-Resistance vs. Temperature

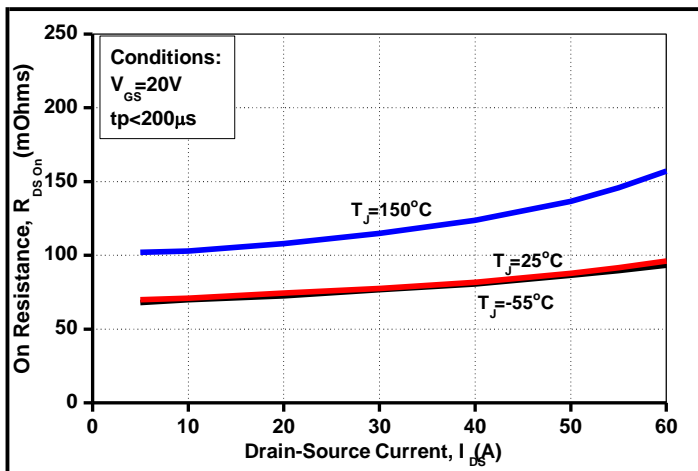


Figure 5. On-Resistance vs. Drain Current
For Various Temperatures

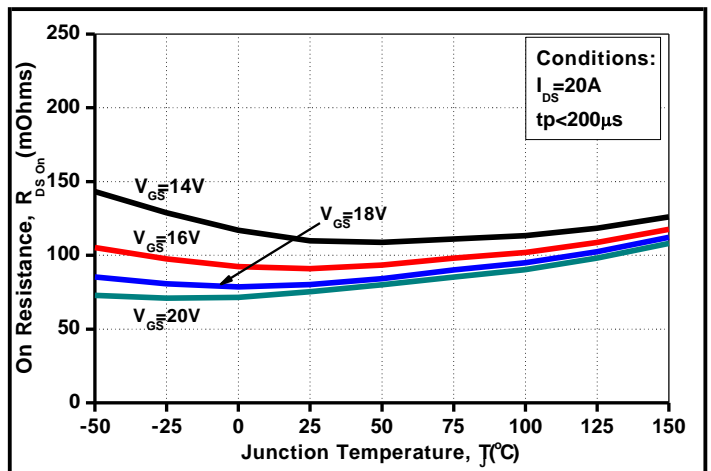


Figure 6. On-Resistance vs. Temperature
For Various Gate Voltage

Typical Performance

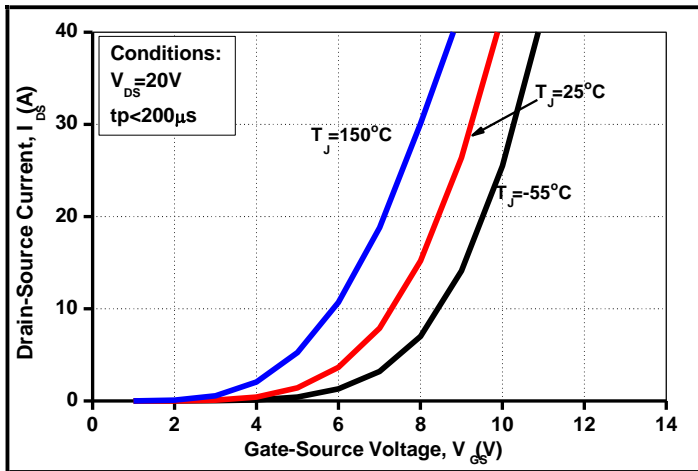


Figure 7. Transfer Characteristic for Various Junction Temperatures

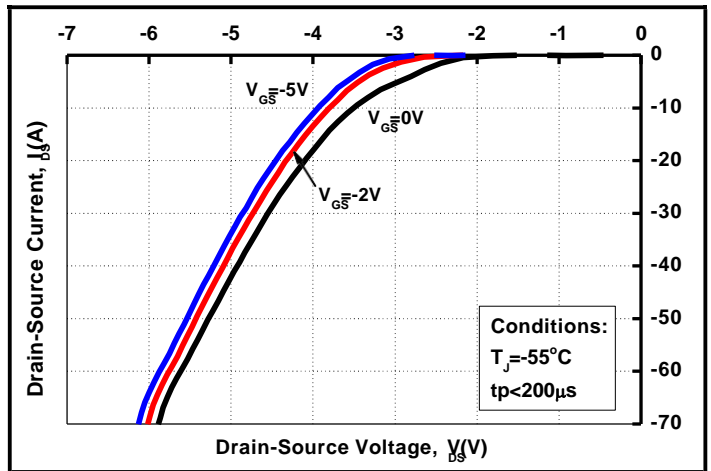


Figure 8. Body Diode Characteristic at -55 °C

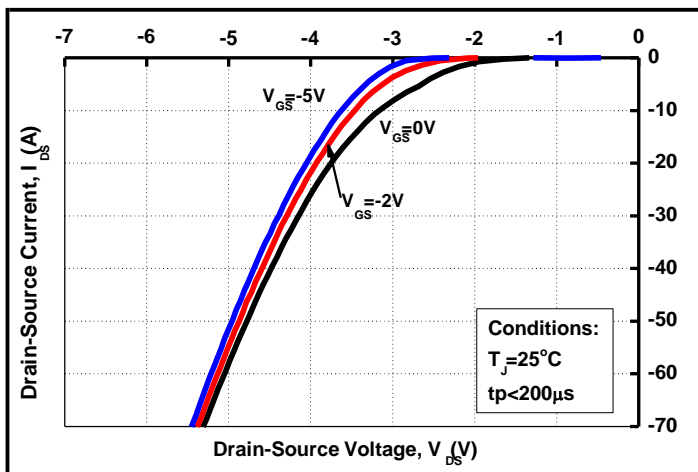


Figure 9. Body Diode Characteristic at 25 °C

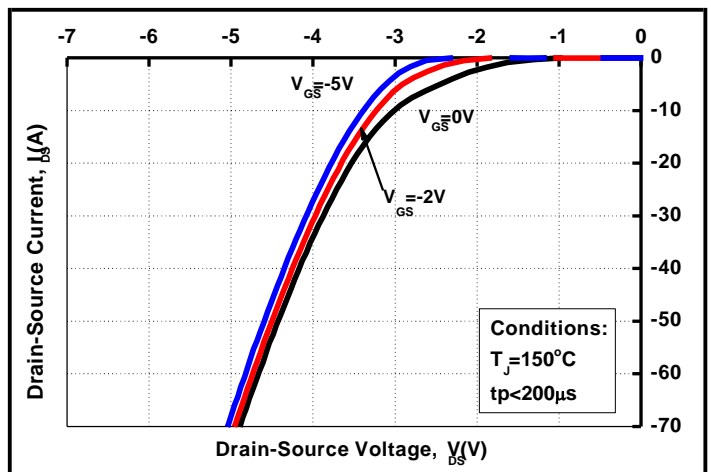


Figure 10. Body Diode Characteristic at 150 °C

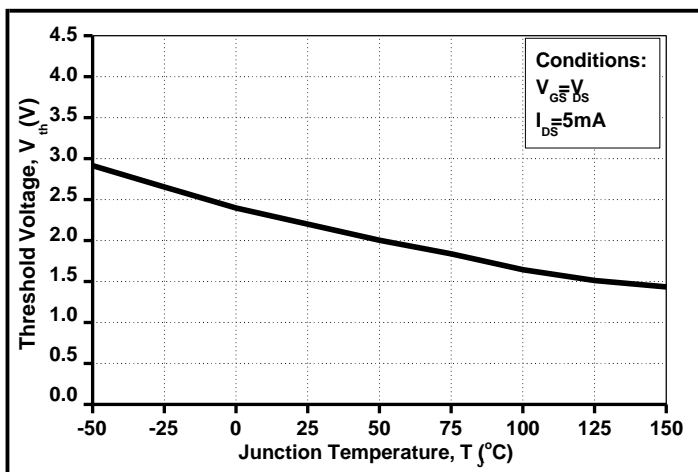


Figure 11. Threshold Voltage vs. Temperature

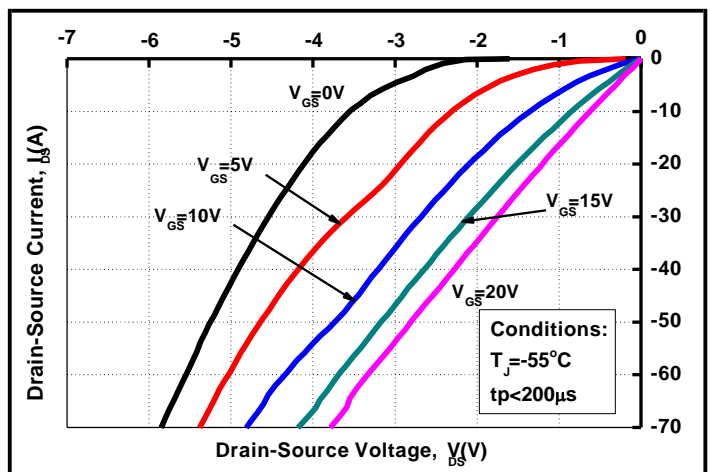


Figure 12. 3rd Quadrant Characteristic at -55 °C

Typical Performance

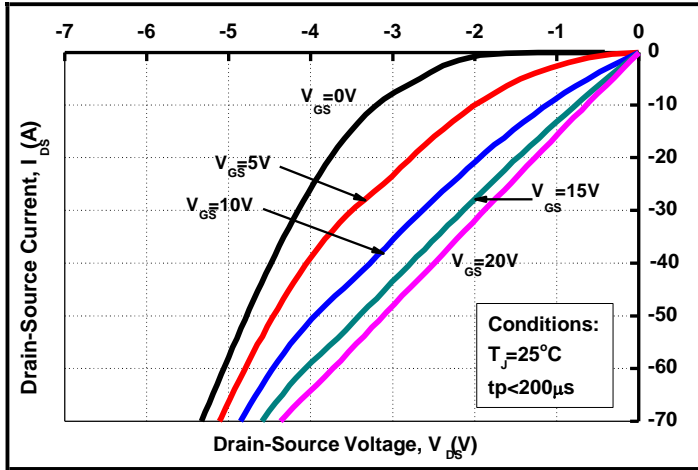


Figure 13. 3rd Quadrant Characteristic at 25 °C

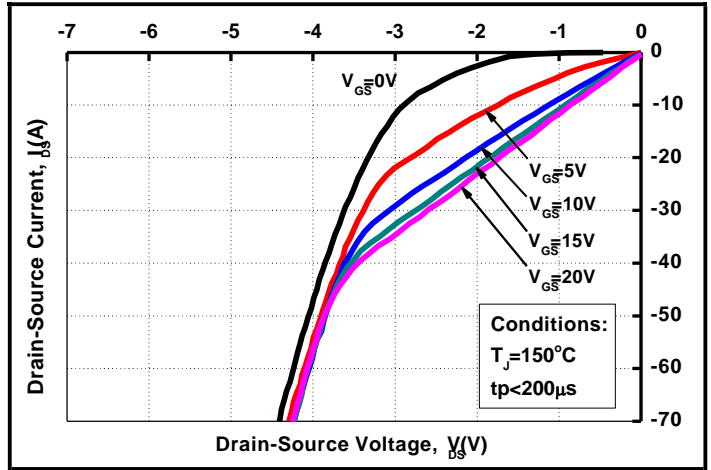


Figure 14. 3rd Quadrant Characteristic at 150 °C

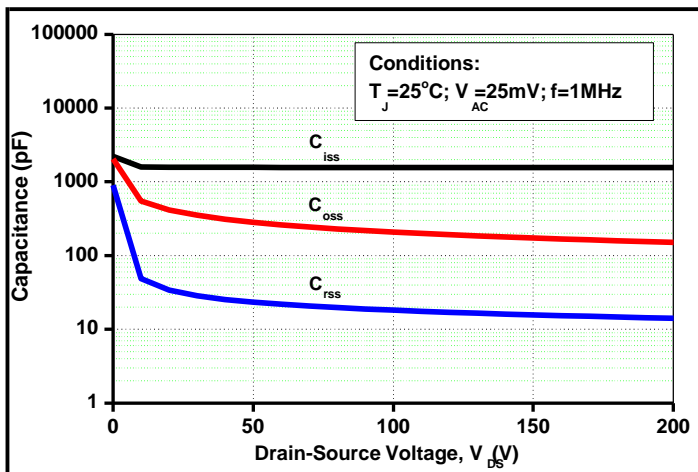


Figure 15. Capacitances vs. Drain-Source Voltage (0 - 200V)

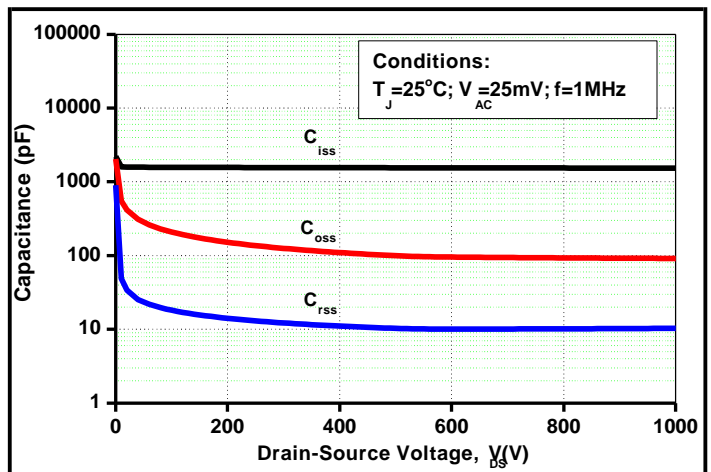
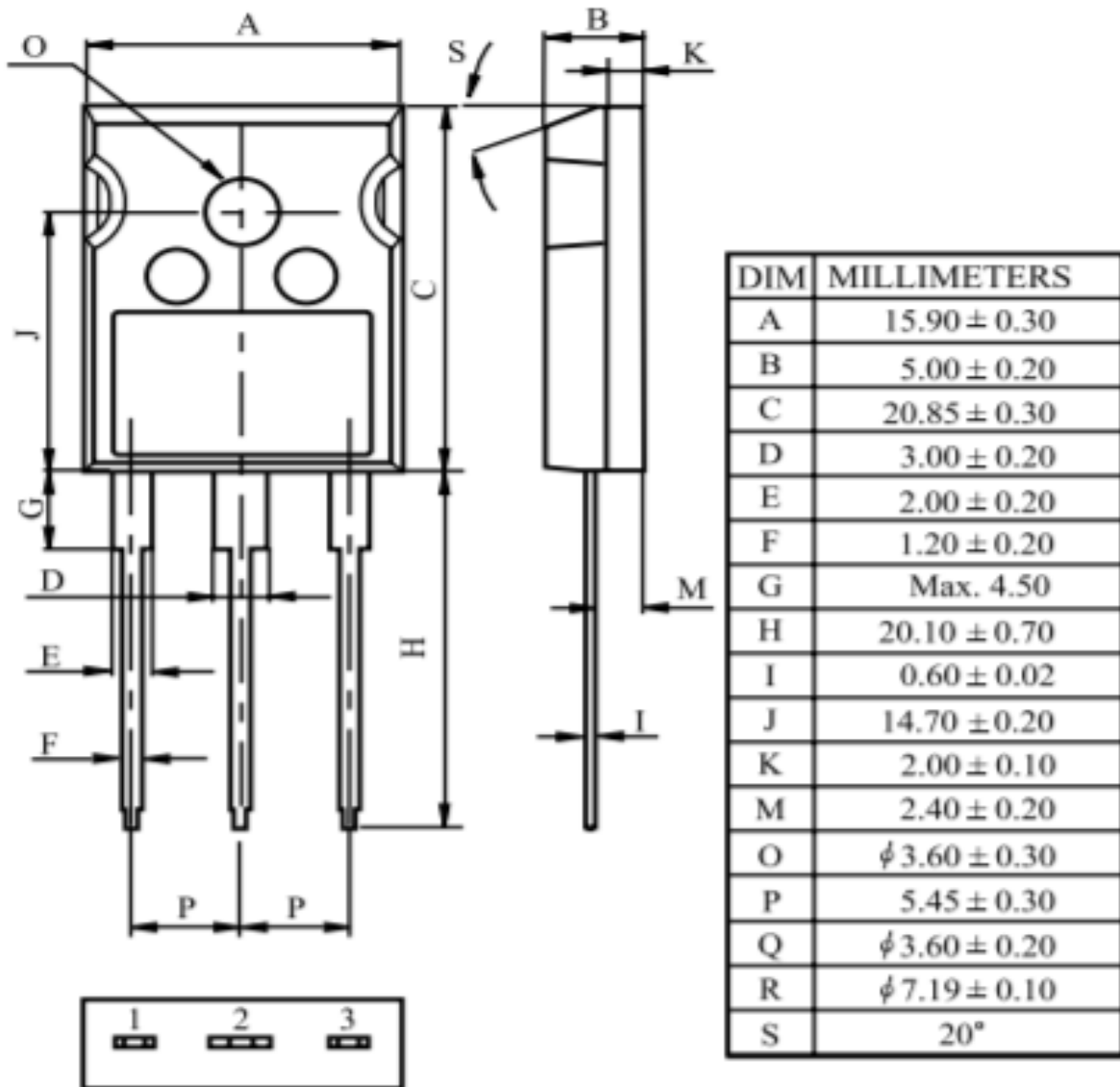


Figure 16. Capacitances vs. Drain-Source Voltage (0 - 1000V)

Package Dimensions

Package TO-247-3



TO-247